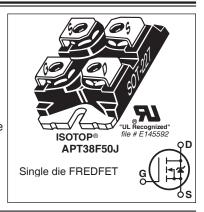




500V, 38A, 0.10Ω Max, $t_{rr} \leq 280$ ns

N-Channel FREDFET

Power MOS 8''' is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced t_{rr} , soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of C_{rss}/C_{iss} result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



FEATURES

- · Fast switching with low EMI
- · Low trr for high reliability
- Ultra low C_{rss} for improved noise immunity
- · Low gate charge
- · Avalanche energy rated
- RoHS compliant

TYPICAL APPLICATIONS

- ZVS phase shifted and other full bridge
- · Half bridge
- · PFC and other boost converter
- Buck converter
- · Single and two switch forward
- Flyback

Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
L	Continuous Drain Current @ T _C = 25°C	38	
'D	Continuous Drain Current @ T _C = 100°C	24	Α
I _{DM}	Pulsed Drain Current ^①	175	
V _{GS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy®	1200	mJ
I _{AR}	Avalanche Current, Repetitive or Non-Repetitive	28	Α

Thermal and Mechanical Characteristics

Symbol	Characteristic		Тур	Max	Unit	
P _D	Total Power Dissipation @ T _C = 25°C			355	W	
$R_{\theta JC}$	Junction to Case Thermal Resistance	hermal Resistance 0.35		0.35	°C/W	
$R_{\theta CS}$	Case to Sink Thermal Resistance, Flat, Greased Surface		0.15			
T _J ,T _{STG}	Operating and Storage Junction Temperature Range			150	°C	
V _{Isolation}	RMS Voltage (50-60hHz Sinusoidal Waveform from Terminals to Mounting Base for 1 Min.)				V	
W _T	Package Weight		1.03		OZ	
			29.2		g	
Torque	Terminals and Mounting Screws.			10	in∙lbf	
				1.1	N·m	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
V _{BR(DSS)}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = 250\mu A$	500			V
$\Delta V_{BR(DSS)}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I _D = 250µA		0.60		V/°C
R _{DS(on)}	Drain-Source On Resistance®	V _{GS} = 10V, I _D = 28A		0.085	0.10	Ω
V _{GS(th)}	Gate-Source Threshold Voltage	V - V I - 2.5mA	3	4	5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Threshold Voltage Temperature Coefficient	$V_{GS} = V_{DS}, I_D = 2.5 mA$		-10		mV/°C
	Zero Gate Voltage Drain Current	$V_{DS} = 500V$ $T_{J} = 25^{\circ}C$			250	
DSS		$V_{GS} = 0V$ $T_J = 125^{\circ}C$			1000	μA
I _{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 30V$			±100	nA

Dvnamic Characteristics

WWW.

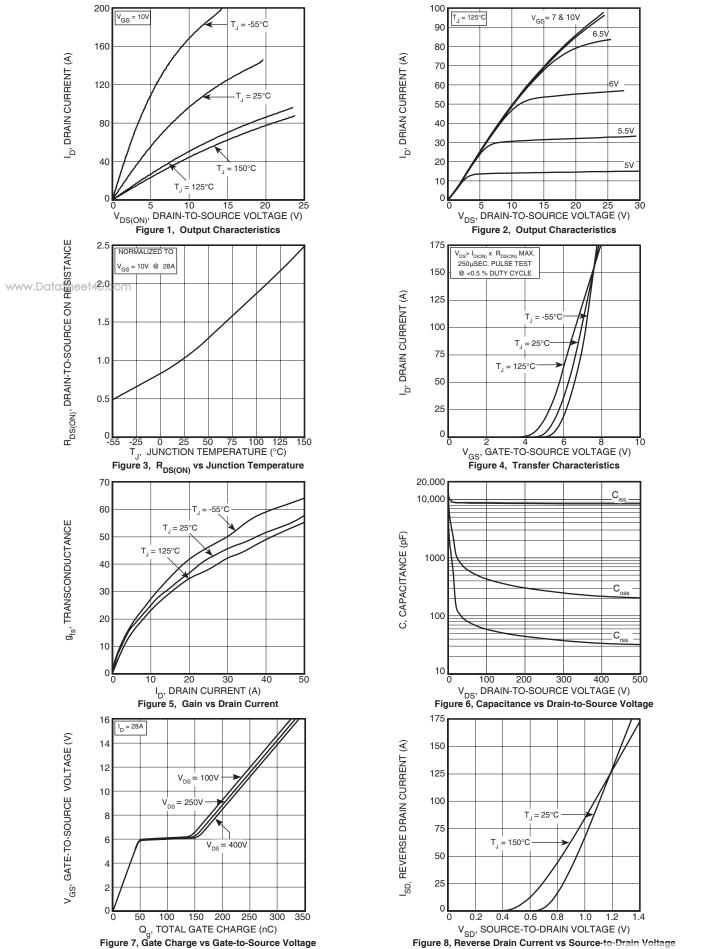
T_{.1} = 25°C unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
9 _{fs}	Forward Transconductance	$V_{DS} = 50V, I_{D} = 28A$		42		S
C _{iss}	Input Capacitance	V 0V V 05V		8800		
C _{rss}	Reverse Transfer Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ f = 1MHz		120		
ataS Ass t4U.	Output Capacitance			945		
C _{o(cr)} ④	Effective Output Capacitance, Charge Related	V = 0V V = 0V to 222V		550		pF
C _{o(er)} ⑤	Effective Output Capacitance, Energy Related	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 333V$		275		
Q_{g}	Total Gate Charge	V 04-40V I 00A		220		
Q_{gs}	Gate-Source Charge	$V_{GS} = 0 \text{ to } 10V, I_{D} = 28A,$ $V_{DS} = 250V$		50		nC
Q_{gd}	Gate-Drain Charge	V _{DS} = 250V		100		
t _{d(on)}	Turn-On Delay Time	Resistive Switching		38		
t _r	Current Rise Time	V _{DD} = 333V, I _D = 28A		45		ns
t _{d(off)}	Turn-Off Delay Time	$R_{G} = 4.7\Omega^{\textcircled{6}}, V_{GG} = 15V$		100		110
t _f	Current Fall Time			33		

Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
I _s	Continuous Source Current (Body Diode)	MOSFET symbol showing the	OD D			38	А
I _{SM}	Pulsed Source Current (Body Diode) (1)	integral reverse p-n junction diode (body diode)	g III			175	A
V _{SD}	Diode Forward Voltage	$I_{SD} = 28A, T_{J} = 25^{\circ}C, V_{GS} = 0V$				1.0	V
t _{rr}	Reverse Recovery Time		T _J = 25°C			280	no
rr			T _J = 125°C			520	ns
Q _{rr}	Reverse Recovery Charge	I _{SD} = 28A ^③	T _J = 25°C		1.20		
, rr		di _{SD} /dt = 100A/μs	T _J = 125°C		3.07		μC
	Reverse Recovery Current	V _{DD} = 100V	T _J = 25°C		10.1		Α
'rrm		T _J = 125°C			14.5		A
dv/dt	Peak Recovery dv/dt	$I_{SD} \le 28A$, di/dt $\le 1000A/\mu s$, $V_{DD} = 333V$, $T_{J} = 125^{\circ}C$				20	V/ns

- ① Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- ② Starting at $T_J = 25$ °C, L = 3.06mH, $R_G = 4.7\Omega$, $I_{AS} = 28$ A.
- 3 Pulse test: Pulse Width < 380µs, duty cycle < 2%.
- (4) $C_{o(cr)}$ is defined as a fixed capacitance with the same stored charge as C_{OSS} with $V_{DS} = 67\%$ of $V_{(BR)DSS}$. (5) $C_{o(er)}$ is defined as a fixed capacitance with the same stored energy as C_{OSS} with $V_{DS} = 67\%$ of $V_{(BR)DSS}$. To calculate $C_{o(er)}$ for any value of V_{DS} less than $V_{(BR)DSS}$, use this equation: $C_{o(er)}$ = -2.04E-7/ V_{DS} ^2 + 4.76E-8/ V_{DS} + 1.36E-10.
- 6 R_G is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)



-to-Drain Voltage 🌣 พพพ.DataSheet4U.com

Rev

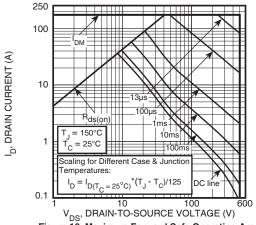


Figure 10, Maximum Forward Safe Operating Area

Z_{EXT} are the external thermal impedances: Case to sink

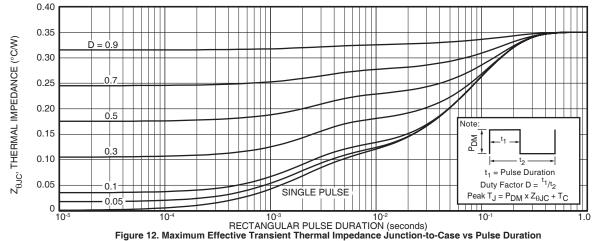
sink to ambient, etc. Set to

zero when modeling only

the case to junction.

T_J (°C) T_C (°C) www.DataSheet4U.com 0.105 0.244 Dissipated Power (Watts) 0.0185 0.360

Figure 11, Transient Thermal Impedance Model



SOT-227 (ISOTOP®) Package Outline

